

Search Notes

Application/Control No.

10/565,975

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

CHOI, IN-HWAN

Art Unit

1792

SEARCHED

Class	Subclass	Date	Examiner
427	255.7	10/16/2008	BT
427	255.29	10/16/2008	BT
427	255.28	10/16/2008	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update keywords search using databases in EAST	10/16/2008	BT
Update inventor's name search	10/16/2008	BT